

### **MOSFET**

### OptiMOS™ 6 Power-Transistor, 40 V

### **Features**

- N-channel, normal level
- Very low on-resistance R<sub>DS(on)</sub>
- Superior thermal resistance
- Optimized design for double side cooling
- 100% avalanche tested
- Pb-free lead plating; RoHS compliant
- Halogen-free according to IEC61249-2-21

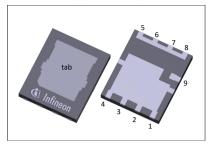
### **Product validation**

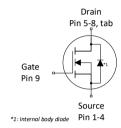
Fully qualified according to JEDEC for Industrial Applications

Table 1 Key performance parameters

Parameter	Value	Unit						
$V_{ m DS}$	40	V						
$R_{\mathrm{DS(on),max}}$	0.49	mΩ						
$I_{D}$	597	А						
$Q_{\rm oss}$	142	nC						
$Q_{G}$	130	nC						

#### PG-WHTFN-9









Type / Ordering code	Package	Marking	Related links
IQD005N04NM6CGSC	PG-WHTFN-9	NA	-

### Public

# OptiMOS™ 6 Power-Transistor, 40 V IQD005N04NM6CGSC



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# OptiMOS™ 6 Power-Transistor, 40 V IQD005N04NM6CGSC



# 1 Maximum ratings

at  $T_A$ =25 °C, unless otherwise specified

Table 2 Maximum ratings

Parameter	Symbol	Values			Unit	Note / Test condition	
raiailletei	Syllibol	Min.	Тур.	Max.	Ollic	Note / Test condition	
Continuous drain current <sup>1)</sup>	I <sub>D</sub>	-	-	597 422 402 57	Α	$V_{\rm GS}$ =10 V, $T_{\rm C}$ =25 °C $V_{\rm GS}$ =10 V, $T_{\rm C}$ =100 °C $V_{\rm GS}$ =6 V, $T_{\rm C}$ =100 °C $V_{\rm GS}$ =10 V, $T_{\rm A}$ =25 °C, $R_{\rm THJA}$ =50 °C/W <sup>2)</sup>	
Pulsed drain current <sup>3)</sup>	I <sub>D,pulse</sub>	-	-	2388	А	<i>T</i> <sub>C</sub> =25 °C	
Avalanche energy, single pulse 4)	E <sub>AS</sub>	-	-	1115	mJ	$I_{\rm D}$ =50 A, $R_{\rm GS}$ =25 $\Omega$	
Gate source voltage	$V_{GS}$	-20	-	20	V	-	
Power dissipation	$P_{\mathrm{tot}}$	_	-	333 3.0	W	$T_{\rm C}$ =25 °C $T_{\rm A}$ =25 °C, $R_{\rm thJA}$ =50 °C/W <sup>2)</sup>	
Operating and storage temperature	$T_{\rm j},T_{\rm stg}$	-55	-	175	°C	-	

<sup>1)</sup> Rating refers to the product only with datasheet specified absolute maximum values, maintaining case temperature as specified. For other case temperatures please refer to Diagram 2. De-rating will be required based on the actual environmental conditions.

### 2 Thermal characteristics

Table 3 Thermal characteristics

Parameter	Symbol	Values			Unit	Note / Test condition
raiametei	Syllibot	Min.	Тур.	Мах.	Ollic	Note / Test condition
Thermal resistance, junction - case, bottom	$R_{thJC}$	-	-	0.45	°C/W	
Thermal resistance, junction - case, top	$R_{thJC}$	-	-	0.56	°C/W	-
Thermal resistance, junction - ambient, 6 cm <sup>2</sup> cooling area <sup>5)</sup>	$R_{thJA}$	-	-	50	°C/W	

Device on 40 mm x 40 mm x 1.5 mm epoxy PCB FR4 with 6 cm $^2$  (one layer, 70  $\mu$ m thick) copper area for source connection. PCB is vertical in still air.

Device on 40 mm x 40 mm x 1.5 mm epoxy PCB FR4 with 6 cm $^2$  (one layer, 70  $\mu$ m thick) copper area for source connection. PCB is vertical in still air.

<sup>3)</sup> See Diagram 3 for more detailed information

<sup>4)</sup> See Diagram 13 for more detailed information

## OptiMOS™ 6 Power-Transistor, 40 V IQD005N04NM6CGSC



### 3 Electrical characteristics

at  $T_{\rm j}$ =25 °C, unless otherwise specified

Table 4 Static characteristics

Parameter	Symbol		Values			Note / Took condition	
rarameter	Symbol	Min.	Тур.	Мах.	Unit	Note / Test condition	
Drain-source breakdown voltage	$V_{(BR)DSS}$	40	-	-	V	$V_{\rm GS}$ =0 V, $I_{\rm D}$ =1 mA	
Gate threshold voltage	$V_{\rm GS(th)}$	1.8	2.3	2.8	V	$V_{\rm DS} = V_{\rm GS}, I_{\rm D} = 1449  \mu \text{A}$	
Zero gate voltage drain current	I <sub>DSS</sub>	-	0.1 10	1 100	μΑ	$V_{\rm DS}$ =40 V, $V_{\rm GS}$ =0 V, $T_{\rm j}$ =25 °C $V_{\rm DS}$ =40 V, $V_{\rm GS}$ =0 V, $T_{\rm j}$ =125 °C	
Gate-source leakage current	I <sub>GSS</sub>	-	10	100	nA	$V_{GS}$ =20 V, $V_{DS}$ =0 V	
Drain-source on-state resistance	$R_{\mathrm{DS(on)}}$	-	0.42 0.48		mΩ	$V_{\rm GS}$ =10 V, $I_{\rm D}$ =50 A $V_{\rm GS}$ =6 V, $I_{\rm D}$ =50 A	
Gate resistance	$R_{G}$	-	0.68	-	Ω	-	
Transconductance	$g_{fs}$	185	370	-	S	$ V_{\rm DS}  \ge 2 I_{\rm D} R_{\rm DS(on)max}, I_{\rm D} = 50 \text{ A}$	

Table 5 Dynamic characteristics

Parameter	Symbol	Values			Unit	Note / Test condition	
raiametei	Symbol	Min.	Тур.	Мах.	Oilit	Note / Test condition	
Input capacitance <sup>6)</sup>	C <sub>iss</sub>	-	9000	1200	) pF		
Output capacitance <sup>6)</sup>	Coss	-	2900	3800	pF	$V_{GS}$ =0 V, $V_{DS}$ =20 V, $f$ =1 MHz	
Reverse transfer capacitance <sup>6)</sup>	C <sub>rss</sub>	-	69	120	pF		
Turn-on delay time	$t_{\sf d(on)}$	-	15	-	ns		
Rise time	$t_{\rm r}$	-	6	-	ns	$V_{DD}$ =20 V, $V_{GS}$ =10 V, $I_{D}$ =50 A,	
Turn-off delay time	$t_{\sf d(off)}$	-	42	-	ns	$R_{\rm G,ext}$ =1.6 $\Omega$	
Fall time	$t_{f}$	-	9	-	ns		

<sup>6)</sup> Defined by design. Not subject to production test.

# OptiMOS™ 6 Power-Transistor, 40 V IQD005N04NM6CGSC



Table 6 Gate charge characteristics 7)

Parameter	Symbol		Values			Note / Took condition	
raiailletei	Syllibot	Min.	Тур.	Max.	Unit	Note / Test condition	
Gate to source charge	$Q_{ m gs}$	-	30	-	nC		
Gate charge at threshold	$Q_{\mathrm{g(th)}}$	-	21	-	nC		
Gate to drain charge <sup>8)</sup>	$Q_{ m gd}$	-	18	26	nC	$V_{\rm DD}$ =20 V, $I_{\rm D}$ =50 A, $V_{\rm GS}$ =0 to 10 V	
Switching charge	$Q_{sw}$	-	27	-	nC		
Gate charge total <sup>8)</sup>	$Q_{ m g}$	-	130	163	nC		
Gate plateau voltage	$V_{ m plateau}$	-	3.3	-	٧		
Gate charge total, sync. FET	$Q_{g(sync)}$	-	122	-	nC	V <sub>DS</sub> =0.1 V, V <sub>GS</sub> =0 to 10 V	
Output charge 8)	$Q_{\rm oss}$	-	142	189	nC	V <sub>DS</sub> =20 V, V <sub>GS</sub> =0 V	

<sup>7)</sup> See "Gate charge waveforms" for parameter definition

### Table 7 Reverse diode

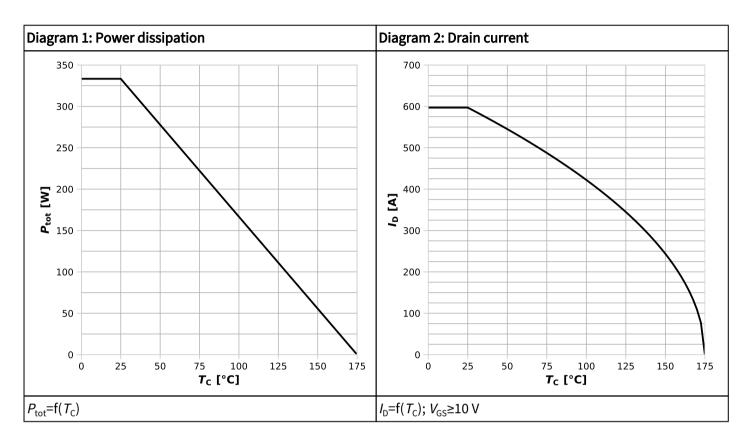
Parameter	Symbol	Values			Unit	Note / Test condition	
raiametei	Symbol	Min.	Тур.	Мах.	Oilit	Note / Test condition	
Diode continuous forward current	Is	-	-	294	А	- <i>T<sub>c</sub></i> =25 °C	
Diode pulse current	I <sub>S,pulse</sub>	-	-	2388	А	7 <sub>C</sub> -23 C	
Diode forward voltage	$V_{\rm SD}$	-	0.78	1.0	٧	$V_{\rm GS}$ =0 V, $I_{\rm F}$ =50 A, $T_{\rm j}$ =25 °C	
Reverse recovery time <sup>9)</sup>	t <sub>rr</sub>	-	58	116	ns	1/-20 \	
Reverse recovery charge <sup>9)</sup>	$Q_{\rm rr}$	-	79	158	nC	$V_{\rm R}$ =20 V, $I_{\rm F}$ =25 A, d $I_{\rm F}$ /d $t$ =100 A/ $\mu$ s	
Reverse recovery time <sup>9)</sup>	t <sub>rr</sub>	-	29	58	ns	$V_{\rm R}$ =20 V, $I_{\rm E}$ =50 A, d $i_{\rm E}$ /d $t$ =1000 A/ $\mu$ s	
Reverse recovery charge <sup>9)</sup>	$Q_{\rm rr}$	-	221	442	nC	ν <sub>R</sub> -20 ν, ι <sub>F</sub> -30 Α, αι <sub>F</sub> /αι-1000 Α/μS	

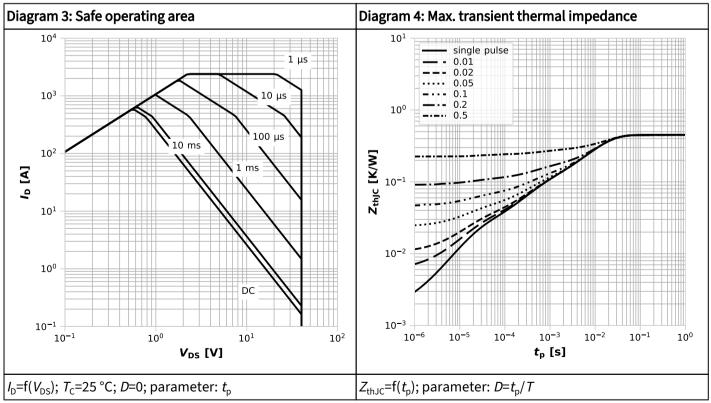
 $<sup>^{9)}</sup>$  Defined by design. Not subject to production test.

<sup>8)</sup> Defined by design. Not subject to production test.

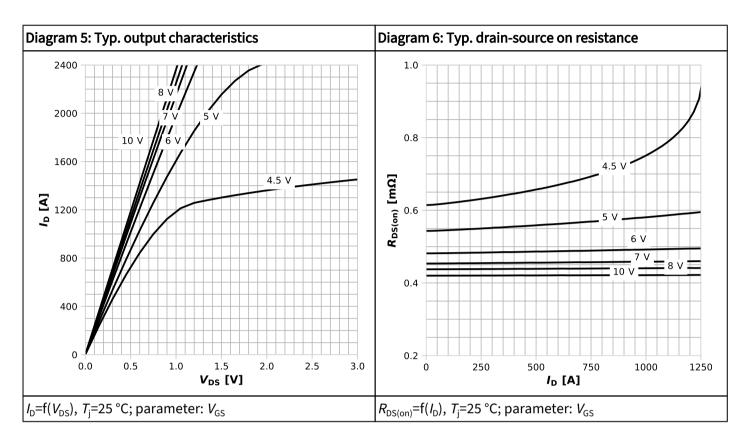


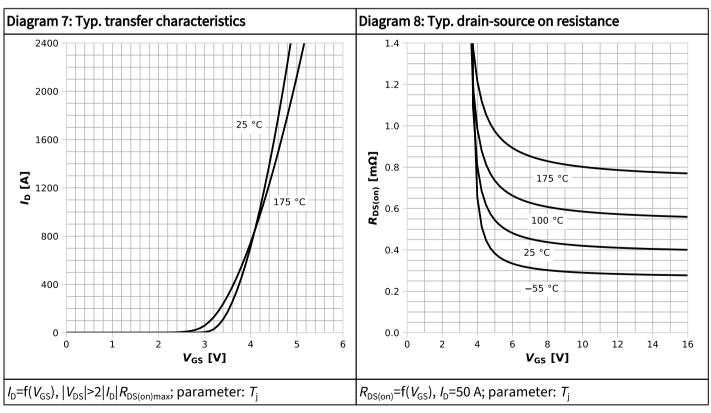
# 4 Electrical characteristics diagrams



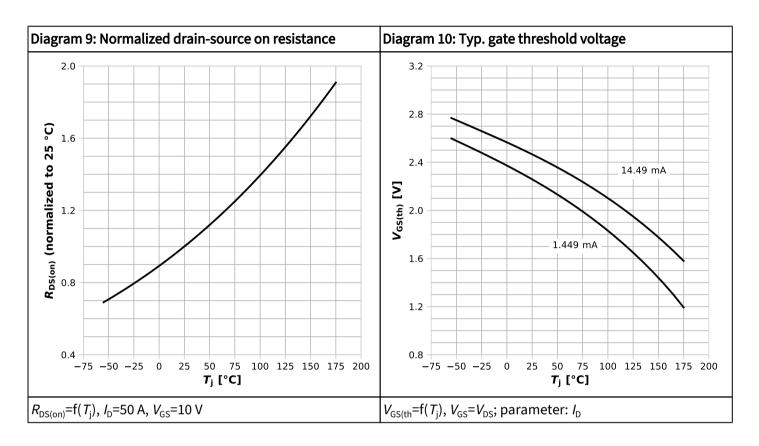


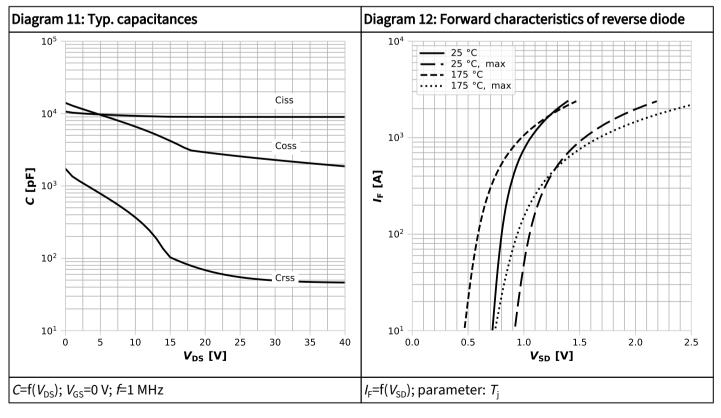




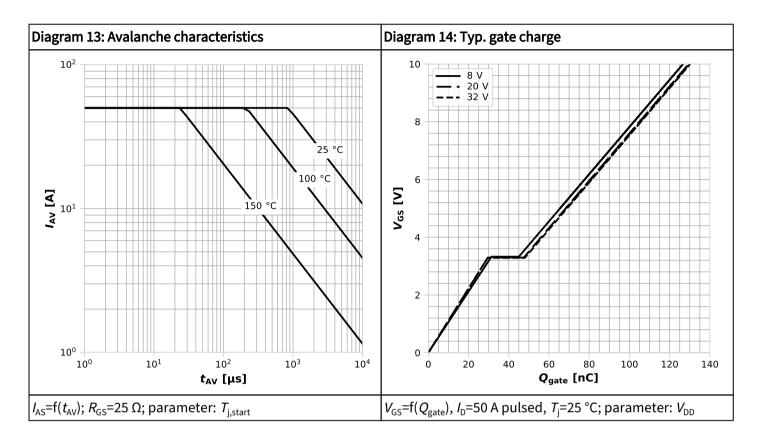


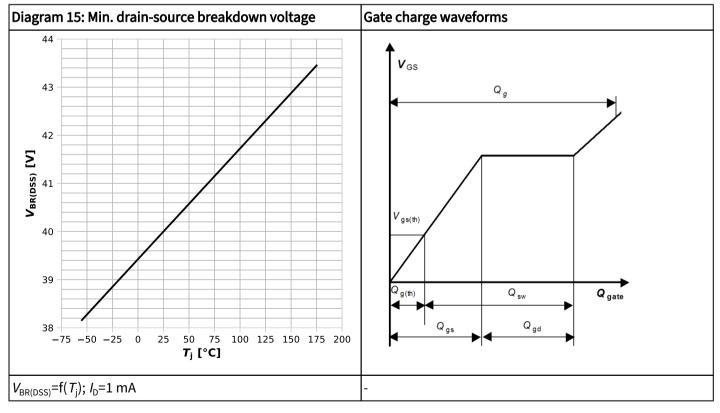






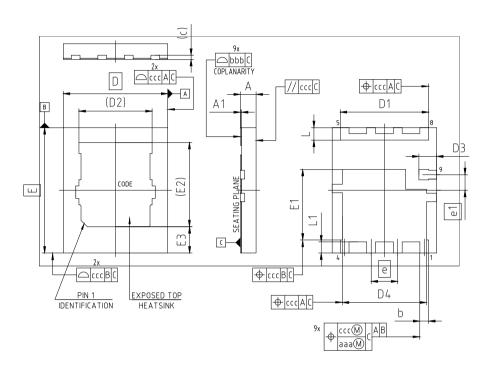








# 5 Package outlines



PACKAGE - GROUP	DG-WHT	FN-9-U02			
NUMBER:	10-1111	114-3-002			
DIMENSIONS	MILLIN	IETERS	DIMENSIONS	MILLIN	METERS
DIMENSIONS	MIN.	MAX.	DIMENSIONS	MIN.	MAX.
Α	0.55	0.75	е	1	.27
A1	0.00	0.05	e1	0	.75
b	0.32	0.52	L	0.50	0.70
С	0.	20	L1	0.44	0.64
D	5.00		aaa	0.05	
D1	4.13	4.33	bbb	0	.08
D2	3.	50	ccc	0	.10
D3	0.75	0.95			
D4	3.93	4.13			
E	6.	00			
E1	3.28	3.48			
E2	4.	03			
E3	1.16	1.36			

NOTE: DIMENSIONS DO NOT INCLUDE MOLD FLASH, PROTRUSION OR GATE BURRS

Figure 1 Outline PG-WHTFN-9, dimensions in mm



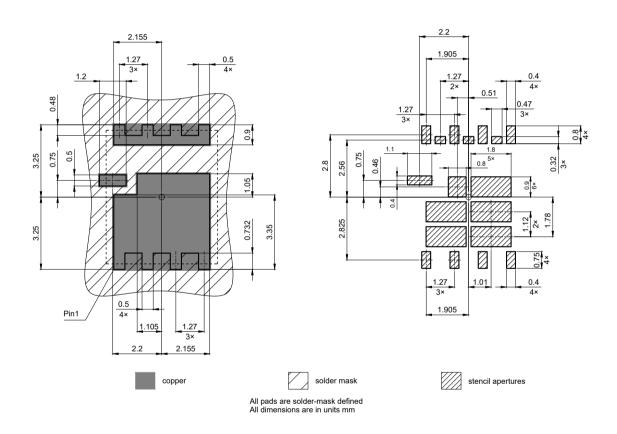


Figure 2 Footprint drawing PG-WHTFN-9, dimensions in mm

### OptiMOS™ 6 Power-Transistor, 40 V IQD005N04NM6CGSC



### **Revision history**

IOD005N04NM6CGSC

#### Revision 2024-10-16, Rev. 2.2

#### Previous revisions

Revision	Date	Subjects (major changes since last revision)
2.0	2024-06-13	Release of final
2.1	2024-07-16	Updated max Rdson
2.2	2024-10-16	Update package drawing and diagram circuit

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